| Search | Notes |
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| Application/Control No. | Applicant(s)/Patent under Reexamination | |
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| 10/710,414 | BILAK ET AL. | |
| Examiner | Art Unit | |
| Alan S. Chen | 2182 | |

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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | |
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| (EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT | 5/26/3006 | ASC | |
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